Application/Control No. Applicant(s)/Patent Under R examination 10/760,500 FURUKAWA ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 2825 Caridad M. Everhart **U.S. PATENT DOCUMENTS** Document Number Date Classification Name Country Code-Number-Kind Code MM-YYYY 07-2002 Harshfield, Steven T. US-6,413,812 438/237 Α US-6,063,688 05-2000 Doyle et al. 438/424 В US-С US-D US-Е US-F US-G US-Н US-US-J Κ US-US-US-М FOREIGN PATENT DOCUMENTS Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U

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